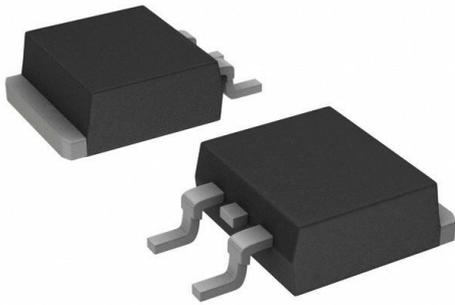


# FQB2N90TM Datasheet

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DiGi Electronics Part Number	FQB2N90TM-DG
Manufacturer	<a href="#">onsemi</a>
Manufacturer Product Number	FQB2N90TM
Description	MOSFET N-CH 900V 2.2A D2PAK
Detailed Description	N-Channel 900 V 2.2A (Tc) 3.13W (Ta), 85W (Tc) Surface Mount TO-263 (D2PAK)



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RFQ Email: [Info@DiGi-Electronics.com](mailto:Info@DiGi-Electronics.com)

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## Purchase and inquiry

Manufacturer Product Number:

FQB2N90TM

Series:

QFET®

FET Type:

N-Channel

Drain to Source Voltage (Vdss):

900 V

Drive Voltage (Max Rds On, Min Rds On):

10V

Vgs(th) (Max) @ Id:

5V @ 250µA

Vgs (Max):

±30V

FET Feature:

-

Operating Temperature:

-55°C ~ 150°C (Tj)

Supplier Device Package:

TO-263 (D2PAK)

Base Product Number:

FQB2

Manufacturer:

onsemi

Product Status:

Obsolete

Technology:

MOSFET (Metal Oxide)

Current - Continuous Drain (Id) @ 25°C:

2.2A (Tc)

Rds On (Max) @ Id, Vgs:

7.20hm @ 1.1A, 10V

Gate Charge (Qg) (Max) @ Vgs:

15 nC @ 10 V

Input Capacitance (Ciss) (Max) @ Vds:

500 pF @ 25 V

Power Dissipation (Max):

3.13W (Ta), 85W (Tc)

Mounting Type:

Surface Mount

Package / Case:

TO-263-3, D2PAK (2 Leads + Tab), TO-263AB

## Environmental & Export classification

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

REACH Status:

REACH Unaffected

HTSUS:

8541.29.0095



April 2000

**QFET™**

# FQB2N90 / FQI2N90

## 900V N-Channel MOSFET

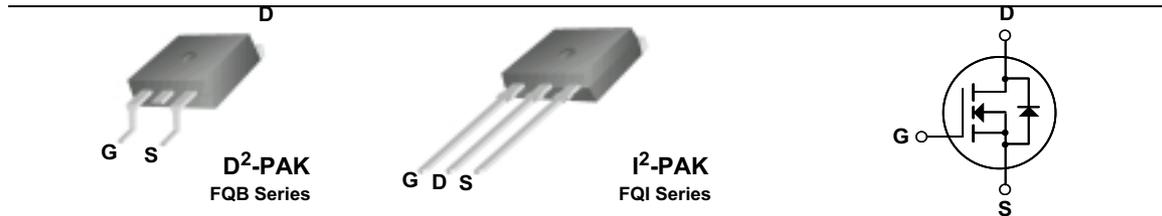
### General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply.

### Features

- 2.2A, 900V,  $R_{DS(on)} = 7.2 \Omega @ V_{GS} = 10 V$
- Low gate charge ( typical 12 nC)
- Low Crss ( typical 5.5 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	FQB2N90 / FQI2N90	Units
V <sub>DSS</sub>	Drain-Source Voltage	900	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)	2.2	A
	- Continuous (T <sub>C</sub> = 100°C)	1.39	A
I <sub>DM</sub>	Drain Current - Pulsed (Note 1)	8.8	A
V <sub>GSS</sub>	Gate-Source Voltage	± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	170	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	2.2	A
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	8.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.0	V
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *	3.13	W
	Power Dissipation (T <sub>C</sub> = 25°C)	85	W
	- Derate above 25°C	0.68	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

### Thermal Characteristics

Symbol	Parameter	Typ	Max	Units
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	--	1.47	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient *	--	40	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	--	62.5	°C/W

\* When mounted on the minimum pad size recommended (PCB Mount)

## Electrical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	900	--	--	V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C	--	1.0	--	V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V	--	--	10	μA
		V <sub>DS</sub> = 720 V, T <sub>C</sub> = 125°C	--	--	100	μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	--	--	100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	--	--	-100	nA

### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	3.0	--	5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.1 A	--	5.6	7.2	Ω
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.1 A (Note 4)	--	2.0	--	S

### Dynamic Characteristics

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz	--	390	500	pF
C <sub>oss</sub>	Output Capacitance		--	45	60	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	5.5	7.0	pF

### Switching Characteristics

t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 450 V, I <sub>D</sub> = 2.2 A, R <sub>G</sub> = 25 Ω  (Note 4, 5)	--	15	40	ns
t <sub>r</sub>	Turn-On Rise Time		--	35	80	ns
t <sub>d(off)</sub>	Turn-Off Delay Time		--	20	50	ns
t <sub>f</sub>	Turn-Off Fall Time		--	30	70	ns
Q <sub>g</sub>	Total Gate Charge		V <sub>DS</sub> = 720 V, I <sub>D</sub> = 2.2 A, V <sub>GS</sub> = 10 V  (Note 4, 5)	--	12	15
Q <sub>gs</sub>	Gate-Source Charge		--	2.8	--	nC
Q <sub>gd</sub>	Gate-Drain Charge		--	6.1	--	nC

### Drain-Source Diode Characteristics and Maximum Ratings

I <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current	--	--	2.2	A	
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current	--	--	8.8	A	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.2 A	--	--	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.2 A, di <sub>F</sub> / dt = 100 A/μs  (Note 4)	--	400	--	ns
Q <sub>rr</sub>	Reverse Recovery Charge		--	1.6	--	μC

#### Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 65mH, I<sub>AS</sub> = 2.2A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 Ω, Starting T<sub>J</sub> = 25°C
3. I<sub>SD</sub> ≤ 2.2A, di/dt ≤ 200A/μs, V<sub>DD</sub> ≤ BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C
4. Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

## Typical Characteristics

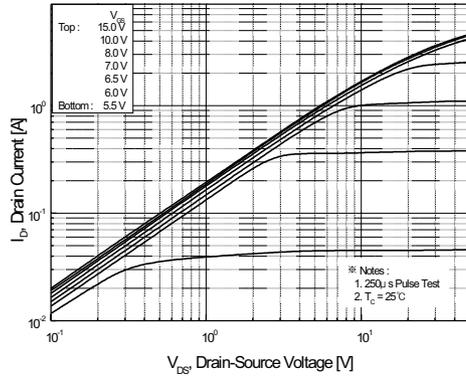


Figure 1. On-Region Characteristics

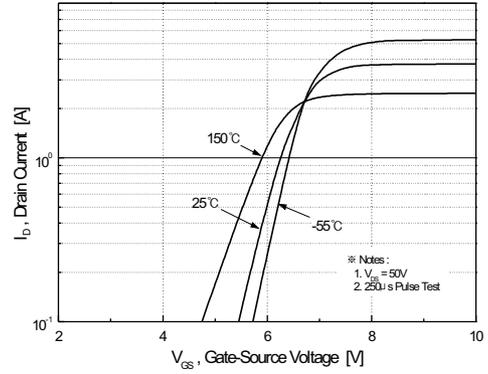


Figure 2. Transfer Characteristics

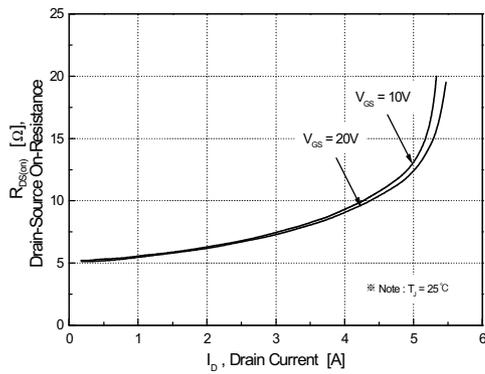


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

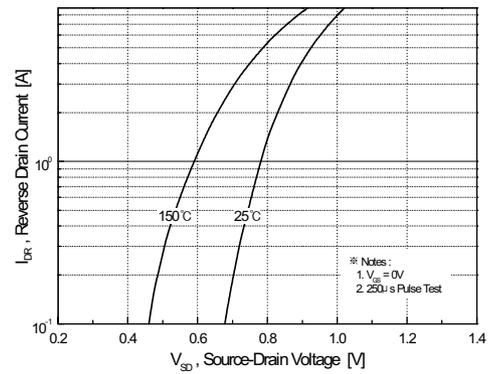


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

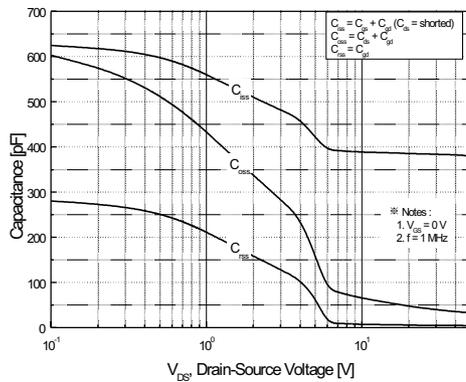


Figure 5. Capacitance Characteristics

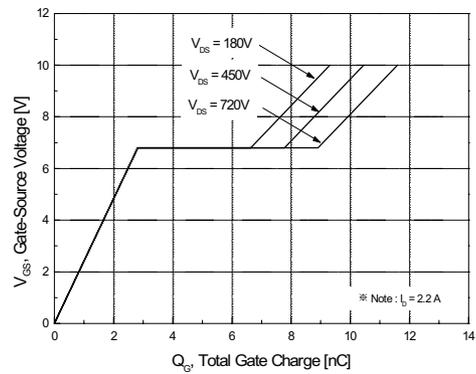
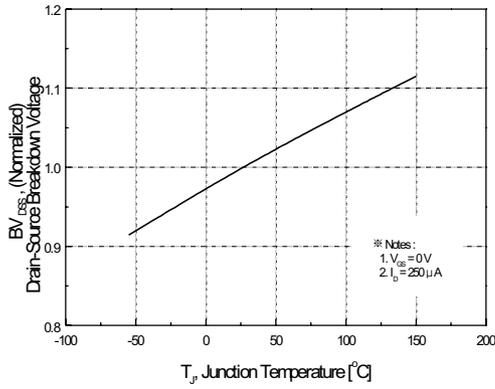
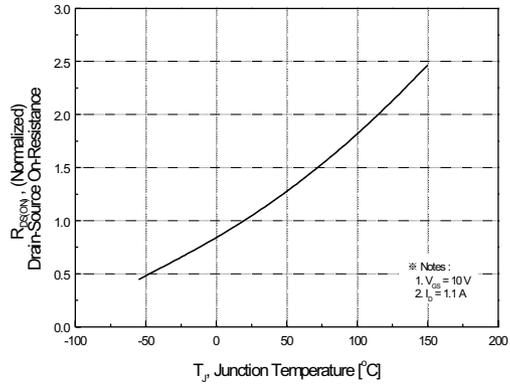


Figure 6. Gate Charge Characteristics

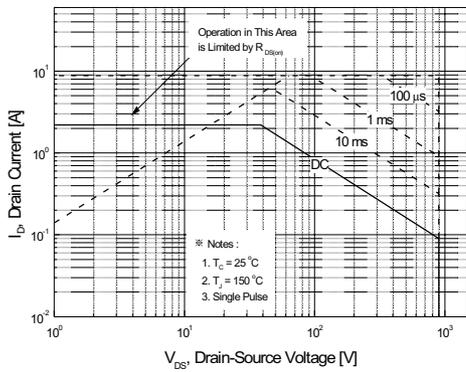
**Typical Characteristics** (Continued)



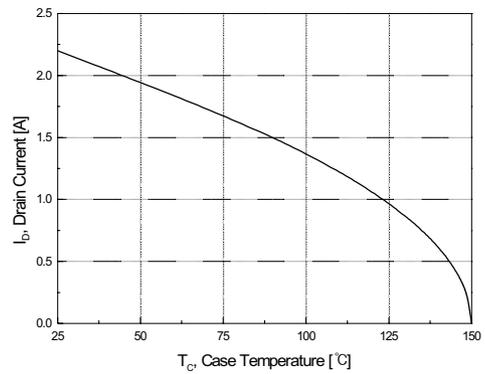
**Figure 7. Breakdown Voltage Variation vs. Temperature**



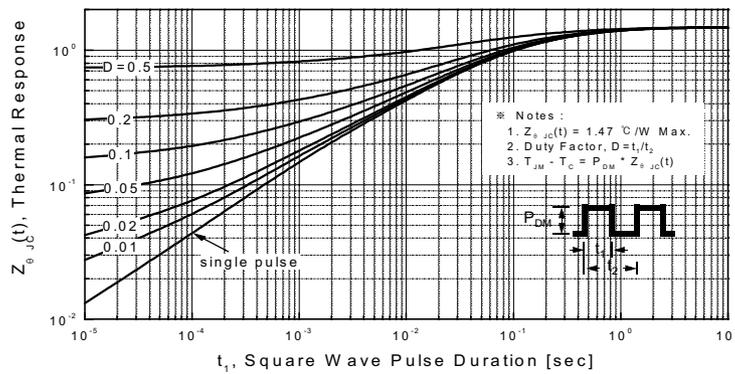
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**

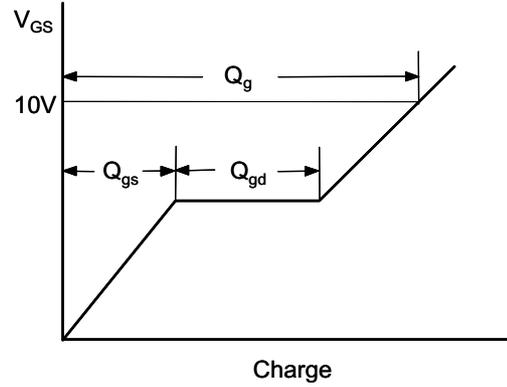
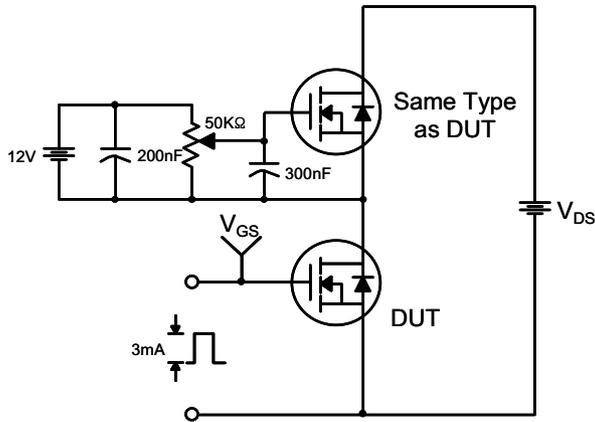


**Figure 10. Maximum Drain Current vs. Case Temperature**

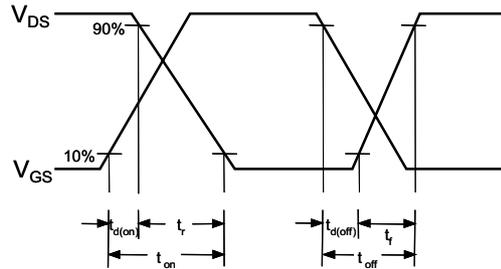
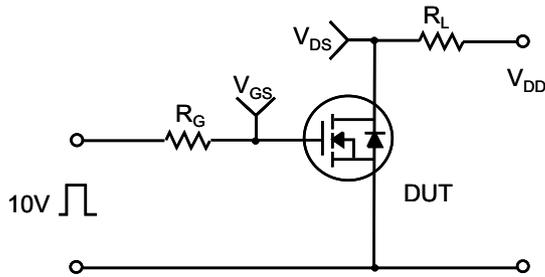


**Figure 11. Transient Thermal Response Curve**

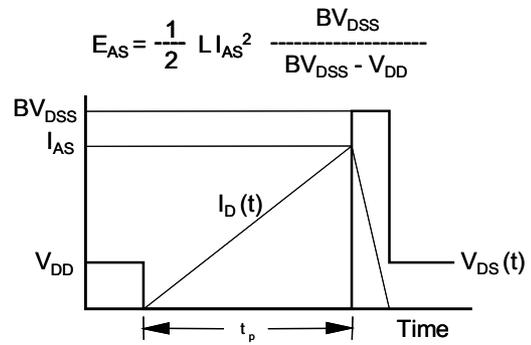
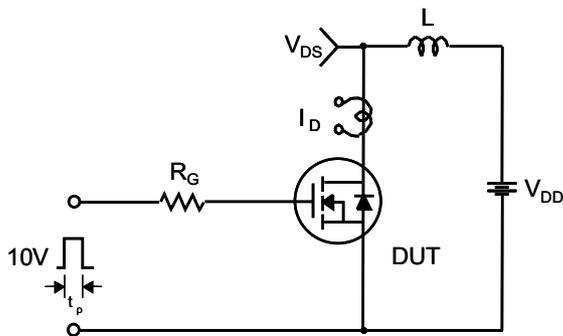
Gate Charge Test Circuit & Waveform



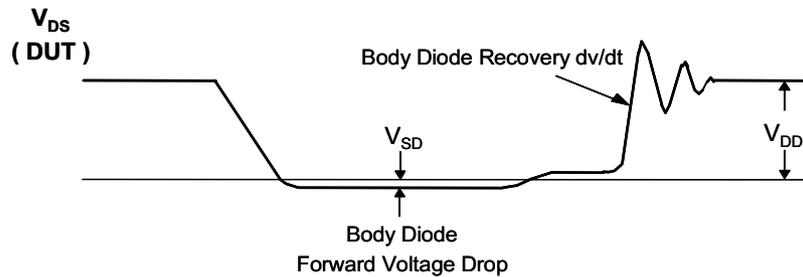
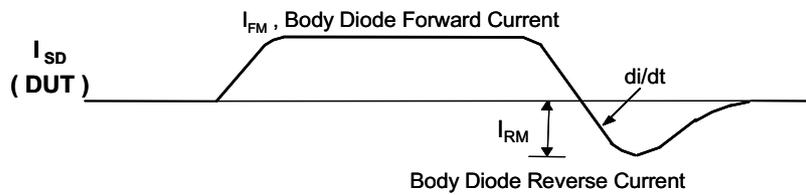
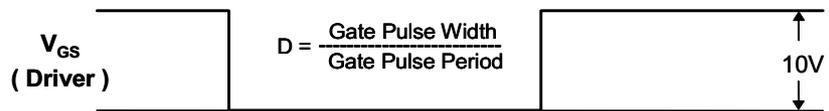
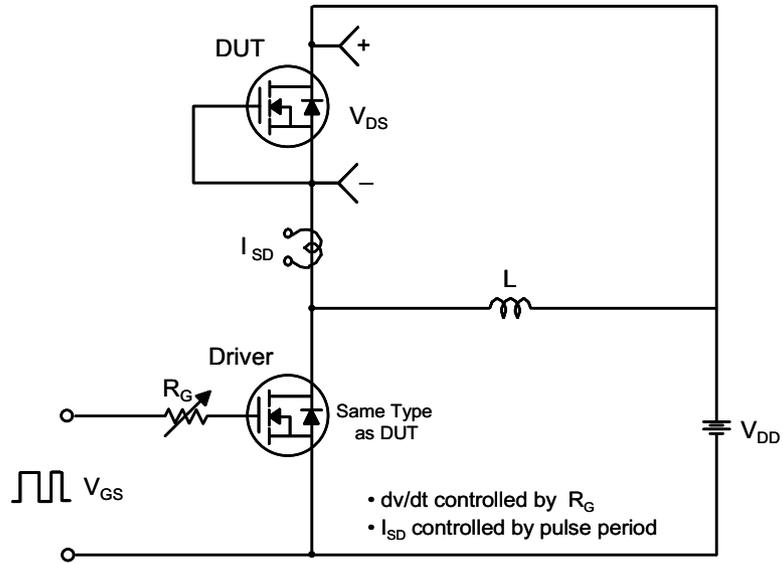
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

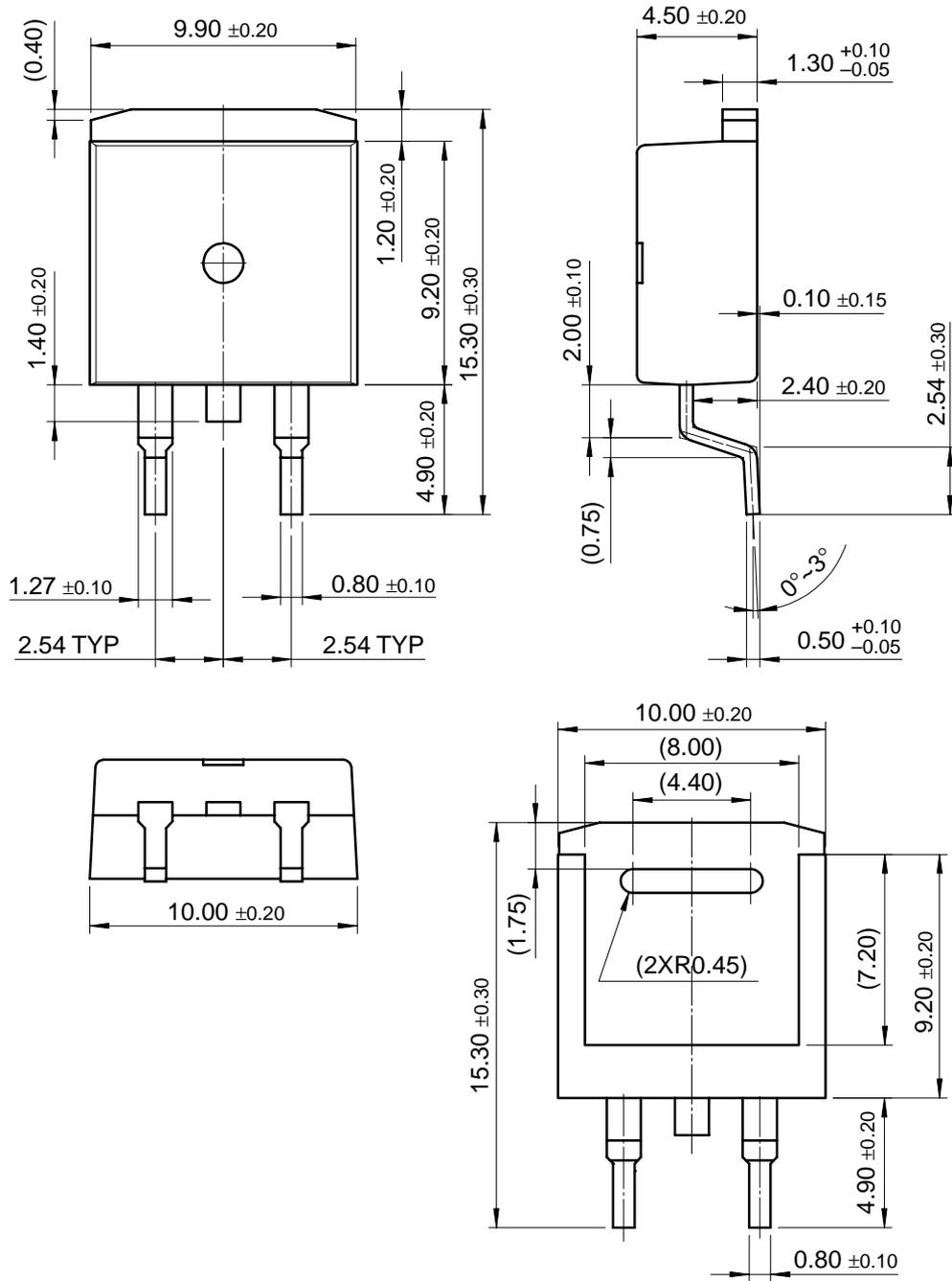


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimensions

D<sup>2</sup>PAK





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Datasheet Identification	Product Status	Definition
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